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INFORMATION	Atty. Docket No.: 56948US024	Serial No.: 10/732,853		
DISCLOSURE	Applicant(s): Erika BELLMANN et al.	Confirmation No.: 8898		
STATEMENT	Application Filing Date: 10 December 2003	Group: 1756		
	Information Disclosure Statement mailed:	June, 2005		

U.S. PATENT DOCUMENTS

Examiner Initial	Capy Englosed	Document Number	Date	Name	Class	Suhelass	Filing Dute If
JA		6,855,384 B1	02-15-05	Nirmal et al.			-

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Examiner	Сору	Document Number	Dote	Country	Cluss	Subclass	Translation	
Initial	Enclosed						Yes	No
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JA	X	Do et al., "Observation of degradation processes of Al electrodes in organic electroluminescence devices by electroluminescence microscopy, atomic force microscopy, scanning electron microscopy, and Auger electron spectroscopy," J. Appl. Phys. 76(9) (1 November 1994): 5118-5121.
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EXAMINER	Date Considered
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PAGE 39/64 * RCVD AT 6/8/2005 3:01:24 PM [Eastern Daylight Time] * SVR:USPTO-EFXRF-1/1 * DNIS:8729306 * CSID:6123051228 * DURATION (mm-ss):21-26